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Proximity-induced ferromagnetism and chemical reactivity in few-layer VSe₂ heterostructuresG. Vinai^{1,*}, C. Bigi^{1,2}, A. Rajan³, M. D. Watson³, T.-L. Lee⁴, F. Mazzola³, S. Modesti^{1,5}, S. Barua^{6,7}, M. Ciomaga Hatnean⁶, G. Balakrishnan⁶, P. D. C. King³, P. Torelli¹, G. Rossi^{1,2} and G. Panaccione^{1,†}¹*Istituto Officina dei Materiali (IOM)-CNR, Laboratorio TASC, Area Science Park, S.S. 14 km 163.5, Trieste I-34149, Italy*²*Department of Physics, Università degli Studi di Milano, Via Celoria 16, I-20133 Milano, Italy*³*SUPA, School of Physics and Astronomy, University of St Andrews, St Andrews KY16 9SS, United Kingdom*⁴*Diamond Light Source Ltd., Harwell Campus, Didcot OX11 0DE, United Kingdom*⁵*Dipartimento di Fisica, Università di Trieste, via Valerio 2, I-34127 Trieste, Italy*⁶*Department of Physics, University of Warwick, Coventry CV4 7AL, United Kingdom*⁷*Department of Physics, Birla Institute of Technology, Mesra 835215, Ranchi, India*

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Among transition-metal dichalcogenides, mono and few-layers thick VSe₂ has gained much recent attention following claims of intrinsic room-temperature ferromagnetism in this system, which have nonetheless proved controversial. Here, we address the magnetic and chemical properties of Fe/VSe₂ heterostructure by combining element sensitive x-ray absorption spectroscopy and photoemission spectroscopy. Our x-ray magnetic circular dichroism results confirm recent findings that both native mono/few-layer and bulk VSe₂ do not show intrinsic ferromagnetic ordering. Nonetheless, we find that ferromagnetism can be induced, even at room temperature, after coupling with a Fe thin film layer, with antiparallel alignment of the moment on the V with respect to Fe. We further consider the chemical reactivity at the Fe/VSe₂ interface and its relation with interfacial magnetic coupling.

DOI: [10.1103/PhysRevB.101.035404](https://doi.org/10.1103/PhysRevB.101.035404)**I. INTRODUCTION**

Two-dimensional (2D) transition metal dichalcogenides (2D-TMDs) have been recently attracting attention due to their unique physical properties when passing from 3D crystals to single or few layers [1–5], with applications ranging in electrocatalysis [6,7], optoelectronics [4], batteries [8,9], piezoelectricity [10], and memory devices [11].

Among dimensionality effects observed in TMDs, metallic VSe₂ is a paradigmatic case. While in its bulk form it displays the onset of charge density waves (CDWs) at 110 K [12–14], in the 2D limit a CDW with enhanced T_C and coupling strength is observed [15–17] (sometimes even considered a metal-insulator transition [15]), and with a different pattern of atomic displacements to the bulk [18,19]. Moreover, its dimensionality-dependent magnetic properties are still under debate. First-principles calculations have predicted that monolayer (ML) VSe₂ might be a 2D itinerant-type ferromagnet, with a magnetic moment per unit cell of about $0.69 \mu_B$ [1,16,20–23]. Although magnetometry measurements reported a strong ferromagnetic response at room temperature [20,24,25], element sensitive spectroscopic results showed no magnetic signal at $V L_{2,3}$ edges, down to cryogenic temperatures [26,27]. Only very recently, a dichroic signal has been reported in the case of chemically exfoliated ML VSe₂, which becomes more pronounced after surface

passivation [28]. Thus, while the most recent studies generally find that quasi-freestanding monolayer VSe₂ is not intrinsically ferromagnetic [18], it remains an interesting open question if ferromagnetism can be coupled into the system, for instance by proximity to a magnetic overlayer.

In this work, we explore the use of such magnetic proximity effects where the magnetic coupling with a ferromagnetic overlayer (Fe in the present case) is used as spectroscopic fingerprint, an approach already used in other 2D systems [17,29–31]. Specifically, we aim at investigating both the intrinsic and the induced magnetism of VSe₂, including its layer dependent behavior, before (i.e., in the pristine case) and after depositing a thin Fe layer on top of it. In our study, based on chemical sensitive techniques such as x-ray absorption spectroscopy (XAS), X-ray magnetic circular dichroism (XMCD), and photoemission spectroscopy (PES), we focus on two aspects: (i) the magnetic state of VSe₂, both as bulk and MLs, and (ii) the chemical stability and/or chemical modifications occurring at the Fe/VSe₂ interface. While XMCD measured at $V L_{2,3}$ edges on pristine 3D and 2D VSe₂ do not display magnetic signal at room temperature [26,27], a clear ferromagnetic signal at room temperature is observed when a Fe overlayer is deposited, with an antiparallel coupling between V and Fe. We also identify a tendency of Se to migrate towards the surface, leading to a (at least partial) metallization of V and therefore to a Fe/V antiferromagnetic coupling. Our element sensitive characterizations of the Fe/2D-VSe₂ heterostructure open the way to further studies on proximity effects on 2D-TMDs, with the aim of reducing the chemical reactivity at the interface and maximizing the proximity-induced magnetic coupling.

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The paper is organized as follows. Section II briefly describes the growth techniques of the MLs and bulk VSe_2 , the decapping procedure and the Fe deposition conditions, together with the experimental setup of the measurements. Section III will focus on the decapped, pristine VSe_2 samples, whereas Sec. IV will concern the study on both the proximity effect and chemical reactivity of the Fe/ VSe_2 heterostructures. Finally, Sec. V will summarize the results and draw the main conclusions.

II. EXPERIMENTAL METHODS

2D- VSe_2 films were grown on graphene (Gr) / SiC substrates using molecular-beam epitaxy (MBE) deposition. Details on the growth technique can be found in Ref. [26]. The number of MLs of the different samples was estimated by calibrating the deposition rate. Samples were then capped with a protective Se layer of few nanometers thickness after growth to allow transferring them in air. Single crystals of VSe_2 were produced by the chemical vapor transport technique [32]. The VSe_2 bulk sample was cleaved in ultrahigh vacuum conditions (base pressure $\sim 1 \times 10^{-10}$ mbar).

XAS, XMCD, and PES measurements were performed at APE-HE beamline at Elettra synchrotron [33]. XAS and XMCD measurements were taken in total electron yield (TEY) mode, normalizing the intensity of the sample current to the incident photon flux current at each energy value. Absorption spectra were taken in circular polarization, with an incident angle of 45° . The XMCD measurements were performed under remanence conditions: i.e., at each energy point of the spectra, alternating magnetic field pulses of ± 300 Oe were applied in the sample plane (exceeding the field strength at which the magnetization saturates), and then the signal was measured in zero applied field in both cases. Dichroic signal intensities were corrected by taking into account both the 75% degree of circular polarization of the incident light and the 45° between the sample magnetization and the photon angular momentum. The spectra were taken both at room temperature and at 100 K. Element sensitive hysteresis loops at the V and Fe edges were taken by selecting the L_3 edge and pre-edge absorption energies of either V or Fe with both phonon helicities and scanning the magnitude of

the magnetic field in the range ± 100 Oe in the sample plane. PES measurements were recorded with an Omicron EA125 hemispherical electron energy analyzer, with the sample at 45° with respect to the impinging linearly polarized light and normal to the surface.

Further experiments were performed at I09 beamline at Diamond Light Source (UK), including low-energy electron diffraction (LEED), PES and angle-resolved photoemission spectroscopy (ARPES) measurements at soft-x ray energies. PES and ARPES measurements were recorded with a VG Scienta EW4000 analyzer, at 75 K in the latter case. The endstation is designed with an angle between the incident beam and the analyzer axis of 87° . Angular dependent PES measurements were taken with an incident angle of 39° , with a $\pm \sim 20^\circ$ range angular dependence, which gives an emission angle (i.e., the angle between the emitted electron and the sample surface normal) between 70° (more grazing, i.e., more surface sensitive) and 30° (more normal, i.e., more bulk sensitive).

After the decapping of the samples, in both experiments the Fe deposition on ML VSe_2 thin films and bulk samples was done via MBE in a preparation chamber connected to the end stations chambers, at a base pressure of 2×10^{-10} mbar, with a deposition rate of $0.65 \text{ \AA}/\text{min}$. All Fe depositions were done at room temperature.

III. PRISTINE VSe_2

The decapping of a protective Se layer deposited atop the MBE-grown samples after growth was done by slowly heating up the sample up to ~ 450 K *in situ* and monitoring via PES the evolution of V $2p$ and Se $3d$ edges during the decapping process, with a impinging photon energy of 900 eV. Figure 1 shows an example of the evolution of the Se $3d$ edges during the decapping. Its initial state (in yellow) corresponds to an amorphous Se^0 state, with its peaks at 54.9 and 54 eV. While heating, the peaks gradually shift, since reaching the Se^{2-} state (in red), with peaks at 53.5 and 52.6 eV for Se $3d_{5/2}$ and $3d_{3/2}$, respectively, for a shift of 1.4 eV between the two states, in good accordance with previously reported PES studies on VSe_2/Se^0 decapping measurements [34]. At the same time, V $2p$ peaks increase in intensity as long as the

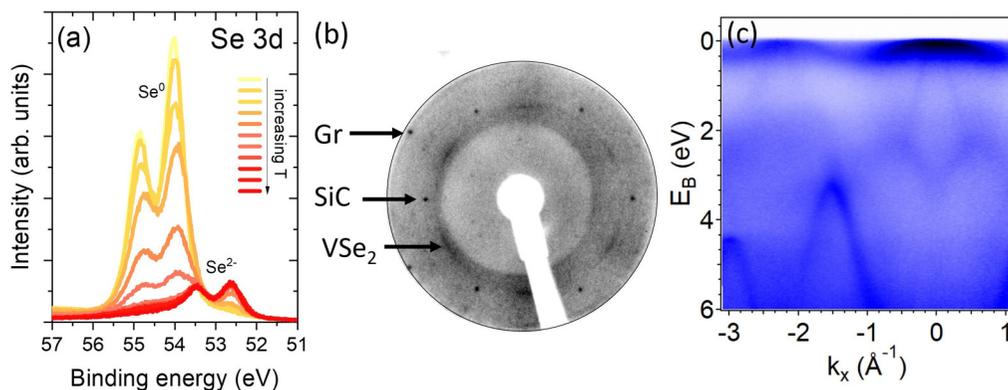


FIG. 1. (a) PES measurements at 900 eV of Se $3d$ edges of a capped 1 ML VSe_2 sample during the decapping process. The sample is heated up during the measurements (yellow to red for increasing temperature). (b) LEED pattern after decapping taken at room temperature at 108 eV. (c) ARPES measurement taken at 75 K at 110 eV.

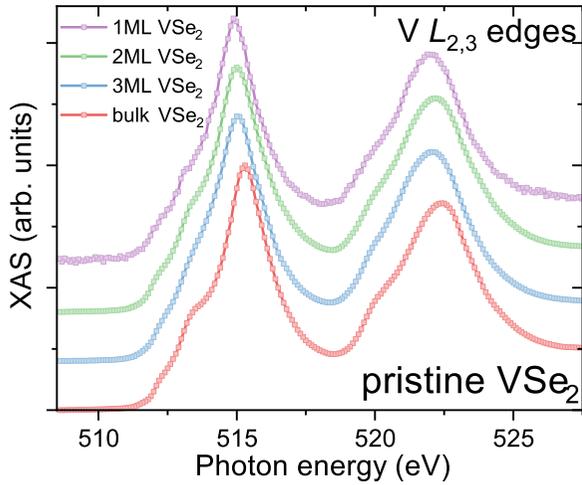


FIG. 2. Normalized XAS measurements at $V L_{2,3}$ edges on VSe_2 MLs after the decapping procedure and VSe_2 bulk after cleaving. All spectra were taken at room temperature.

temperature increases (Fig. S1 in the Supplemental Material [35]). The initial peaks present shoulders, probably due to contamination coming from the air, which disappear once the capping is fully removed. The final $V 2p$ edges have $2p_{3/2}$ and $2p_{1/2}$ peaks at 513 and 520.5 eV, i.e., with a spin-orbit coupling of 7.5 eV [27].

The quality of the complete decapping of the surface and of the 2D- VSe_2 was verified via LEED and ARPES measurements [Figs. 1(b) and 1(c)]. The LEED pattern on clean 2D- VSe_2 [Fig. 1(c)], measured at room temperature at 108 eV, shows (i) the sharp spots coming from both the Gr underlayer and the SiC substrate, and (ii) the elongated Bragg spots of the 2D- VSe_2 layer, due to the distributed rotational domains of the ML, consistent with recent observations in similar systems [26]. No signs of charge density waves are visible, which are expected to appear below 110 K. The ARPES measurement, taken at 75 K at 110 eV [Fig. 1(d)] along K - Γ - M axis, shows the $V 3d$ band localized close to the Fermi edge and the $Se 4p$ bands dispersing downward, centered on $k_x = 0$ [15,26,27].

Figure 2 shows the XAS spectra at $V L_{2,3}$ edges taken on both bulk and MLs VSe_2 films after the removal of capping Se layer. Both 3D and 2D samples present a $4+$ state, with $L_{2,3}$ peaks of 2D samples with energies shifted to lower values of 0.3 eV with respect to the bulk one. All samples present a shoulder before L_3 edge, at 513.3 eV, particularly pronounced in the case of bulk sample. $L_{2,3}$ peaks positions at 514.8 and 522 eV, respectively, for the ML thin films place them at energy values lower than what reported for VO_2 [36–40] and higher than metallic V (reported at 512 eV) [41], whereas the bulk sample has a slightly shifted L_3 edge, at 515.3 eV. It is important to remark that these features were present also before the decapping process, which therefore, did not modify the chemical properties of the VSe_2 MLs. An example of comparison between the XAS spectra before and after the decapping is shown in Fig. S2 in the Supplemental Material [35], for the case of 3 ML VSe_2 .

Regarding the magnetic behavior of VSe_2 before Fe deposition, no sign of dichroic signal was detected on any of the samples within the instrumental sensitivity limits, confirming what was previously reported on similar samples by the same technique [26,27]. In the following, such a lack of dichroic signal will be discussed by comparing it with the case of the proximity-induced magnetism in the Fe/ VSe_2 heterostructure.

IV. Fe/ VSe_2 HETEROSTRUCTURES

A. Proximity induced ferromagnetism

Figure 3 shows the XAS and XMCD spectra at $V L_{2,3}$ edges taken before (light colors) and after (dark colors) the 2-nm Fe deposition, for both the 1ML case [Fig. 3(a)] and the bulk VSe_2 [Fig. 3(b)] sample, together with the XAS and XMCD spectra at Fe $L_{2,3}$ edges of the 1ML case [Fig. 3(c)]. All spectra are measured at room temperature.

First, we focus on the comparison of the XAS spectra. In Fig. 3(a), we can notice that the 1ML VSe_2 sample presents a general shift of $V L_{2,3}$ edges towards lower energies after Fe deposition compared to the pristine case, together with a smoothing of the L_3 pre-edge features. Similar modifications were observed for all MLs samples. Such shift is an

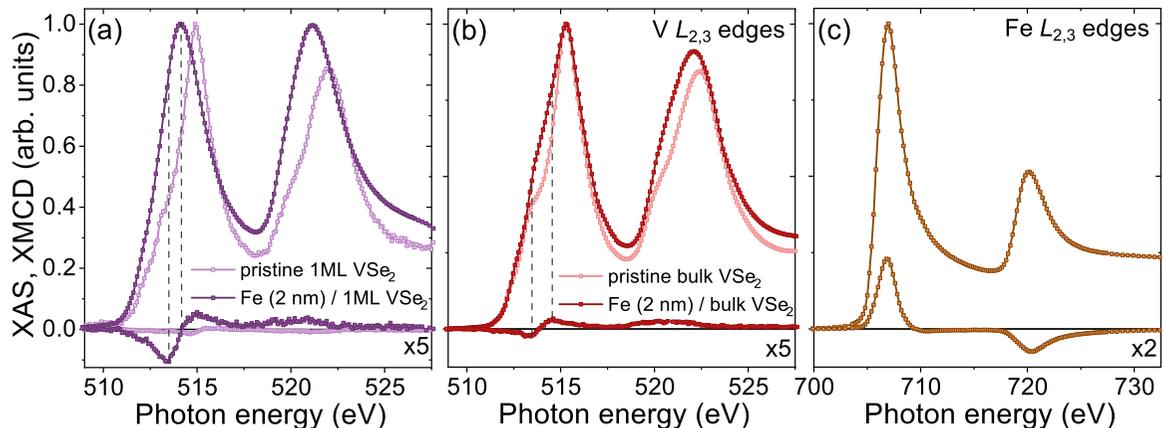


FIG. 3. (a),(b) XAS and XMCD spectra at $V L_{2,3}$ edges on pristine VSe_2 (light colors) and Fe (2 nm) / VSe_2 (dark colors), for 1ML (a) and bulk (b) samples. XMCD spectra are multiplied by a factor 5. (c) XAS and XMCD at Fe $L_{2,3}$ edges for Fe (2 nm) / 1ML VSe_2 . All spectra are measured at room temperature.

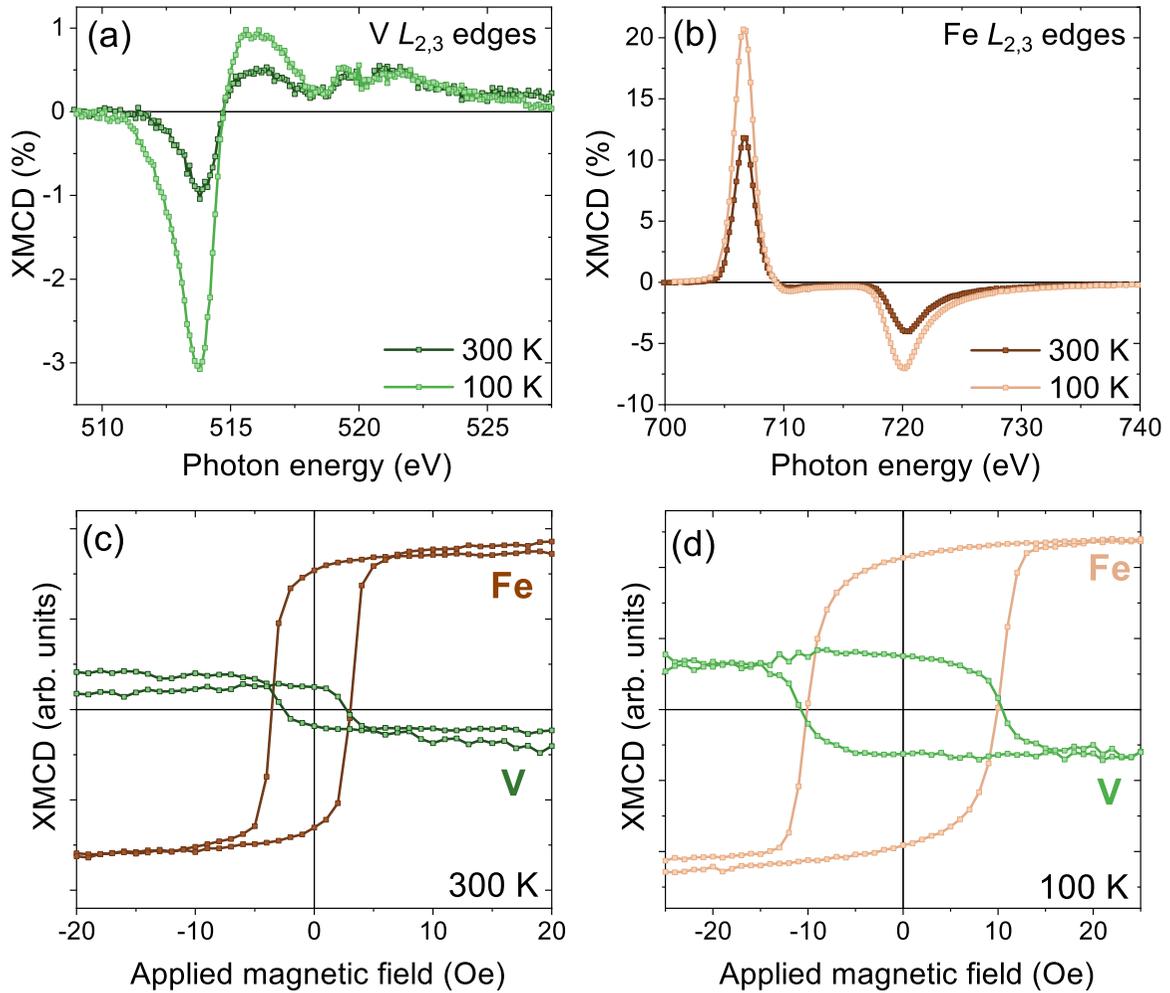


FIG. 4. (a),(b) XMCD spectra at (a) V and (b) Fe $L_{2,3}$ edges on Fe (2nm) / 2ML VSe₂ sample at 300 K (dark) and 100 K (light); (c),(d) Element sensitive hysteresis loops at Fe and V L_3 edges on Fe (2nm) / 2ML VSe₂ sample at (c) 300 K and (d) 100 K.

indicator of a possible chemical modification of the ML upon Fe deposition, with a tendency of V to metallize towards a V^0 state, as will be further discussed in the following. In the case of the bulk sample [Fig. 3(b)], the position and width of the L_3 edge remain unchanged after Fe deposition, whereas the pre-edge is modified, with an increase of its signal intensity.

Regarding the XMCD, Fig. 3(a) shows a comparison between the XMCD signal of 1ML VSe₂ sample before and after Fe deposition, both magnified by a factor of 5 with respect to the XAS sum spectra. In the case of the Fe/2D-VSe₂ heterostructure, a clear L_3 asymmetry peak is measured. The maximum of the asymmetry takes place on the L_3 pre-edge at 513.5 eV, with an intensity of 2.3%, while its value goes to zero on the L_3 edge (514 eV). In the case of the 2 and 3 MLs samples, their dichroic signal was 1.2% and 1.4%, respectively. Together with the XMCD of the heterostructure, Fig. 3(a) shows the dichroic signal of V for the pristine 1ML VSe₂. We can observe that no features are present in correspondence to the L_3 asymmetry of the heterostructure, while the signal intensity, below 0.3%, is inside the instrumental sensitivity limit [42]. In the case of bulk VSe₂, the XMCD features are much less defined than in the 2D cases, with an

asymmetry of 0.5%. Interestingly, the photon energy value of the maximum of the asymmetry of the 3D sample (513.5 eV) is the same of the 2D ones. This suggests that for both ML and bulk samples the contribution to the dichroic signal comes from the interface. Whereas in the former case the whole sample is affected by the interfacial coupling because of its 2D nature, in the latter one the TEY probing depth of ~ 5 –7 nm integrates over a thicker volume of the sample, thus the interfacial chemical modifications of V are mostly covered by the unmodified signal coming from below the interface. The presence of positive and negative features at L_3 edge are due to the small spin-orbit splitting of V $L_{2,3}$ edges, which tends to mix the $2p_{1/2}$ and $2p_{3/2}$ states [43,44].

Corresponding to the dichroic signal of V, Fig. 3(c) shows the XAS and XMCD spectra at Fe $L_{2,3}$ edges of the same Fe (2 nm) / 1ML VSe₂ sample. The L_3 dichroic signal intensity at Fe edge is 23%, i.e., the Fe layer thickness was not large enough to have a full Fe magnetization at room temperature [45]. Similar values of Fe dichroic signals were obtained for all samples. V and Fe dichroic signals are opposite in sign, which is indicating an antiparallel coupling between the two in the film plane. A similar antiparallel coupling has been recently observed on Co/ML-VSe₂ heterostructures [46].

By using the sum rules [45], it is possible to estimate the total magnetic moment of V in the heterostructure. This operation requires great care because of two aspects: (a) the small spin-orbit energy separation between L_2 and L_3 edges, which increases the error bar of the measured values, and (b) the possible coexistence of metallic V and VSe_2 . Indeed, the evolution of the XAS V spectra upon Fe deposition opens questions on the chemical stability of the ML, or more generally on the interfacial layer, since XAS spectra show a tendency of V to metallize towards a V^0 state, with the shift of L_3 edges towards lower energies. The appearing antiferromagnetic coupling between Fe and V is consistent with what has been observed via XMCD measurements in the case of metallic Fe/V interfaces [43,47–51]. The shape of the measured XMCD shown in Fig. 3 has good resemblance with the dichroic signal reported in the case of Fe/V multilayers [43], which reports a total magnetic moment of V of $0.26 \mu_B$. In the case of 2D- VSe_2 , the theoretically predicted total magnetic moment of V is of about $0.69 \mu_B$ [16]. Because of these considerations, both 4+ and purely metallic V states have been considered. By normalizing the measured Fe dichroic signal for the bulk value of Fe of $2.18 \mu_B$, we obtain a total magnetic moment of V that has its maximum value for the 1ML case of the order of $0.16 \pm 0.08 \mu_B$, a value closer to the metallic V case than to the VSe_2 one.

To further prove the antiferromagnetic coupling at the interface, we measured element sensitive hysteresis loops on both V and Fe edges, at room temperature and at 100 K. Figure 4 shows the evolution of the ferromagnetic response of Fe / 2ML VSe_2 heterostructure. Figures 4(a) and 4(b) show the XMCD signals at (a) V and (b) Fe $L_{2,3}$ edges at 300 K and 100 K. Both V and Fe dichroic signals proportionally increase once cooled down, confirming an interfacial exchange coupling between the two elements. The antiferromagnetic interfacial coupling is moreover confirmed by element sensitive hysteresis loops at Fe and V L_3 edges. Figures 4(c) and 4(d) show the hysteresis loops of Fe (2nm) / 2ML VSe_2 sample at (c) 300 K and (d) 100 K. The signal of the V follows the magnetic response of the Fe layer, with identical coercive field and opposite sign. At room temperature, Fe presents a coercive field of 4 Oe and a ratio between remanence magnetization and saturation magnetization M_r/M_{sat} ratio of $\sim 80\%$, with V with antiparallel alignment. At 100 K, Fe coercive field reaches 10 Oe, with similar M_r/M_{sat} ratio.

Despite that we did not measure the case of a nonmagnetic material deposited on top of VSe_2 , we do not expect in this case any dichroic signal coming from metallic V. Indeed, in literature no XMCD signal at metallic V $L_{2,3}$ edges is reported in few-layers V/nonmagnetic metal systems [50,52]. These measurements support other experimental proofs of the lack of V ferromagnetic behavior in the absence of another ferromagnetic layer [53,54], contradicting earlier works on similar interfaces [55,56].

B. Chemical reactivity at Fe/ VSe_2 interface

To have an in depth understanding of the interfacial coupling taking place at the Fe/ VSe_2 interface, surface sensitive spectroscopic characterizations such as PES, ARPES, and LEED measurements were taken, comparing a pristine 1ML

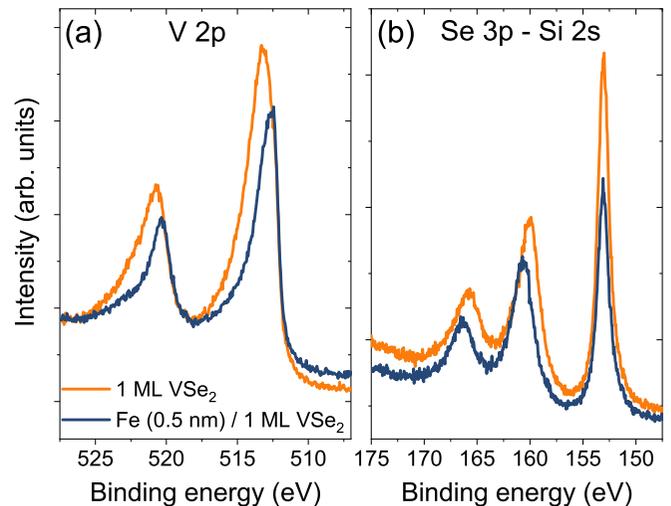


FIG. 5. PES measurements at 900 eV on 1 ML VSe_2 after decapping (orange) and after 0.5 nm Fe deposition (blue): (a) V $2p$ edge, (b) Se $3p$ and Si $2s$ edges.

VSe_2 sample and the same sample after 0.5-nm Fe deposition. Figure 5 shows a comparison of PES spectra, taken at 900 eV before and after 0.5-nm Fe deposition at V $2p$ (a) and at Se $3p$ and Si $2s$ (b) edges. A series of modification at these edges occurring between the two stages suggests how the creation of a Fe/ VSe_2 interface affects the features of the whole VSe_2 ML. First, V $2p$ peaks shift towards lower binding energies [Fig. 5(a)], with a shift of V $2p_{3/2}$ of -0.5 eV (from 513.1 to 512.6 eV). In the meantime, Se $3p$ shifts towards higher binding energies [Fig. 5(b)], with a shift of Se $3p_{3/2}$ of $+0.5$ eV, whereas Si $2s$ peak, coming from the substrate, remains unmodified. These energy shifts are a signature of an intermixing between VSe_2 and Fe after Fe deposition. Regarding Se $3d$ edge, its $3d_{3/2}$ and $3d_{1/2}$ peaks at 54.3 and 53.5 eV measured after decapping, characteristic of VSe_2 MLs [34], are overlapping with Fe $3p$ edge after 0.5-nm Fe deposition. The Se $3d$ features are therefore not recognizable anymore, and are replaced by a broad Fe $3p$ edge (Fig. S3 in the Supplemental Material [35]). The signs of an intermixing between VSe_2 and Fe were also confirmed by the LEED and ARPES measurements. After Fe deposition, the LEED pattern measured in the same conditions showed no features. Whereas the spots of the Gr/Si substrate, already weak on the pristine ML VSe_2 , are hardly detectable since almost out of the probing depth of the measurements, the Bragg spots of VSe_2 are not measurable anymore, while no spots due to Fe deposition are detected (Fig. S4 in the Supplemental Material [35]). This loss of information implies a loss in details in ARPES features too, which are almost completely covered by the broadly dispersive band of Fe (Fig. S5).

A direct proof of the interfacial intermixing can be seen via an element sensitive depth profile of the Fe (0.5 nm) / 1 ML VSe_2 interface, by means of angular dependent PES measurements. Figure 6 shows the angular dependent evolution of the peak intensities of the PES spectra at Fe $2p_{3/2}$, Se $3p_{3/2}$, V $2p_{3/2}$, and Si $2s$ edges on Fe (0.5 nm) / 1 ML VSe_2 sample, as a function of the emission angle. Measurements were taken by changing the photon energy in order

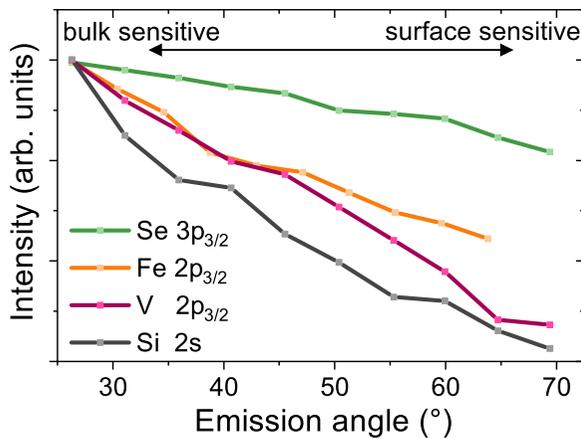


FIG. 6. Angular dependent evolution of the peak intensities of the PES spectra at Se $3p_{3/2}$, Fe $2p_{3/2}$, V $2p_{3/2}$, and Si $2s$ peaks on Fe (0.5 nm) / 1 ML VSe₂ sample, as a function of the emission angle.

to have a kinetic energy of 250 eV at the main edge for all spectra. This allows having comparable probing depths among the spectra, i.e., correctly comparing the depth profiles of the different elements. Nonuniformities due to the analyzer were taken into account by normalizing the curves using a reference background (i.e., a flat photoemission spectrum). Finally, the intensities were corrected by taking into account the photoelectron angular distribution parameters for each element [57]. The intensities were, therefore, normalized to one at the smallest emission angle, i.e., at the most bulk sensitive measurements.

In the case of an element confined at a certain height of the sample stack, the peak intensity is expected to decrease monotonically with the increase of the emission angle, with a larger slope for elements far from the surface [58]. In Fig. 6, the Si $2s$ peak signal (in grey), coming from the substrate, acts as a reference. In the case of Fe $2p_{3/2}$ and V $2p_{3/2}$ peaks, the slope is reduced, with a signal of Fe slightly larger than the one of V at large emission angles. We can therefore consider Fe stably confined on top of the ML and V below the deposited Fe layer. Se $3p_{3/2}$ peak, on the other hand, shows a strongly reduced slope, which indicates the tendency of Se to segregate from the 2D-VSe₂ and migrate towards the surface, thus inducing the metallization of V, as shown in the previous

paragraph. Se is known to easily form Se-Fe bonding; a similar interfacial chemical reaction has been observed at the Fe/ZnSe interface, independently on the ZnSe initial surface termination [59].

V. CONCLUSIONS

We have presented an element sensitive characterization of the magnetic and chemical properties of VSe₂, from bulk down to few layers, both in the pristine case and in the Fe/VSe₂ heterostructure. No intrinsic ferromagnetism, as due to the absence of dichroic signal, is observed on pristine samples, at any thickness. After depositing the Fe overlayer, an antiparallel aligned dichroic signal appears at V and Fe $L_{2,3}$ edges, indicating ferromagnetism as due to magnetic proximity effect. The estimated moment of $0.16 \pm 0.08 \mu_B$ leads to a clearly observable signal here, while no dichroic signal is evident for the pure monolayer without Fe coverage, putting stringent constraints on the magnitude of any possible magnetic moment in pristine VSe₂. Indeed, our results are thus in strong support of recent observations that the pristine MBE-deposited VSe₂ monolayer is not ferromagnetic.

For the proximity-coupled system studied here, the combination of XAS, PES, LEED, ARPES, and angular dependent PES shows how the structural and chemical order of interfacial VSe₂ is endangered upon Fe deposition. A tendency of V to metallize towards a V⁰ state, originating from the Se propensity to migrate towards the surface, is observed.

Our results show that the chemical stability of ML-VSe₂ upon deposition of a metallic ferromagnetic layer may be partially lost. In the meantime, the clear proximity-induced coupling at the interface between V and Fe motivates us to further explore different ferromagnetic/2D-TMDC heterostructures.

The research data supporting this publication can be accessed at [60].

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